

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/611,554	BAXTER, MICHAEL S.	
		Examiner	Art Unit	Page 1 of 1
		Rick K. Chang	3729	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,329,693 A	07-1994	Smith, Larry D.	29/764
*	B	US-6,915,563 B2	07-2005	Bolde et al.	29/762
*	C	US-5,224,263 A	07-1993	Hamburgen, William R.	29/762
*	D	US-5,375,319 A	12-1994	Jacobs, Joseph M.	29/762
*	E	US-5,579,571 A	12-1996	Park et al.	29/762
*	F	US-6,779,256 B2	08-2004	Kappel et al.	29/764
*	G	US-6,202,294 B1	03-2001	Bogannam, Daniel C.	29/764
*	H	US-5,842,261 A	12-1998	Ortiz, Daniel C.	29/426.5
*	I	US-6,219,905 B1	04-2001	Bolleson, Vernon P.	29/764
*	J	US-4,970,779	11-1990	Chen, Ing-Wen	29/764
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.